Search Notes		

Application/Control No.	Applicant(s)/Patent und Reexamination	er
10/042,616	FLANAGAN, MARK J.	
Examiner	Art Unit	
Trenton J. Roche	2193	

SEARCHED			
Class	Subclass	Date	Examiner
717	100-103	11/29/2004	TR
715	512	11/29/2004	TR
705	11	11/30/2004	TR
updated	above	7/8/2005	TR
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
East Search	11/29/2004	TR	
ACM, IEEE, CiteSeer Search	11/29/2004	TR	